

AOSP66923

100V N-Channel AlphaSGT™

General Description

Trench Power MOSFET - AlphaSGT[™] technology

- Low R_{DS(ON)}
- Logic Level Driving
- $\bullet \ \, \text{Excellent} \ \, Q_G \ \, x \ \, R_{DS(ON)} \ \, \text{Product (FOM)} \\$
- RoHS and Halogen-Free Compliant

Applications

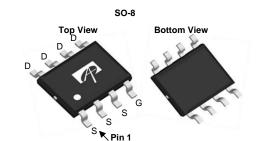
• High Frequency Switching and Synchronous Rectification

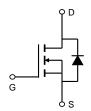
Product Summary

 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 12A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 11 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 15 m\Omega \end{array}$

100% UIS Tested 100% Rg Tested







Orderable Part Number	Orderable Part Number Package Type		Minimum Order Quantity	
AOSP66923	SO-8	Tape & Reel	3000	

Absolute Maximum Ratings T _A =25°C unless otherwise noted					
Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V_{DS}	100	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _A =25°C		12		
Current	T _A =70°C	I _D	9.5	A	
Pulsed Drain Current ^C		I _{DM}	48		
Avalanche Current ^C		I _{AS}	30	А	
Avalanche energy	L=0.1mH	E _{AS}	45	mJ	
	T _A =25°C	В	3.1	W	
Power Dissipation ^B	T _A =70°C	P _D	2.0	VV	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics					
Parameter		Symbol	Тур	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	31	40	°C/W
Maximum Junction-to-Ambient AD	Steady-State		59	75	°C/W
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	16	24	°C/W



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC F	STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A,\ V_{GS}=0V$	100			V	
I _{DSS} Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V			1			
	Zero Gate Voltage Drain Current	T _J =55°C			5	μA	
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V			±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_D=250\mu A$	1.6	2.1	2.6	V	
		V _{GS} =10V, I _D =12A		9.2	11	mΩ	
R _{DS(ON)} Static Drain-Source On-Resistance	Static Drain-Source On-Resistance	T _J =125°C		16	19.5	11122	
		V _{GS} =4.5V, I _D =10A		11.7	15	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =12A		50		S	
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.72	1	V	
Is	Maximum Body-Diode Continuous Current				4	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance		1300	1725	2100	рF	
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =50V, f=1MHz	250	360	480	pF	
C _{rss}	Reverse Transfer Capacitance		2	7.5	15	pF	
R_g	Gate resistance	f=1MHz	0.3	0.8	1.3	Ω	
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge			25	35	nC	
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =12A		12.5	18	nC	
Q_{gs}	Gate Source Charge	VGS-10V, VDS-30V, ID-12A		6		nC	
Q_{gd}	Gate Drain Charge	1		3.5		nC	
Q _{oss}	Output Charge	V_{GS} =0V, V_{DS} =50V		30		nC	
t _{D(on)}	Turn-On DelayTime			8.5		ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =4.15 Ω ,		3		ns	
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		23		ns	
t _f	Turn-Off Fall Time]		3.5		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =12A, di/dt=500A/μs		33		ns	
Q_{rr}	Body Diode Reverse Recovery Charge	I_F =12A, di/dt=500A/ μ s		120		nC	

A. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}=150^\circ$ C, using $\leqslant 10s$ junction-to-ambient thermal resistance. C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^\circ$ C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.

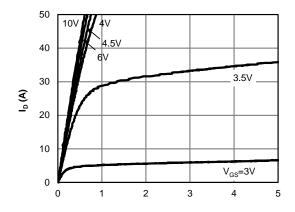
D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

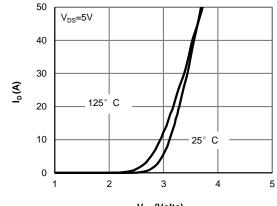
F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(\text{MAX})}$ =150° C. The SOA curve provides a single pulse rating.



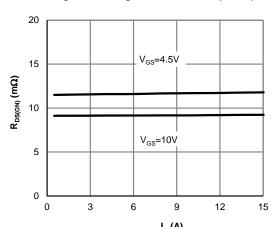
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



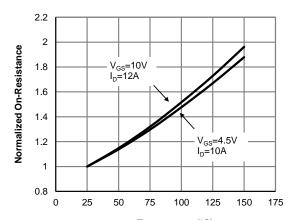
V_{DS} (Volts) Figure 1: On-Region Characteristics (Note E)



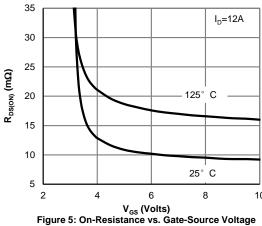
V_{GS} (Volts) Figure 2: Transfer Characteristics (Note E)



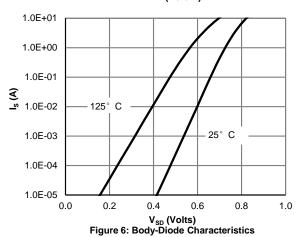
 $\label{eq:ldot} {\rm I_D}\left({\rm A}\right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)

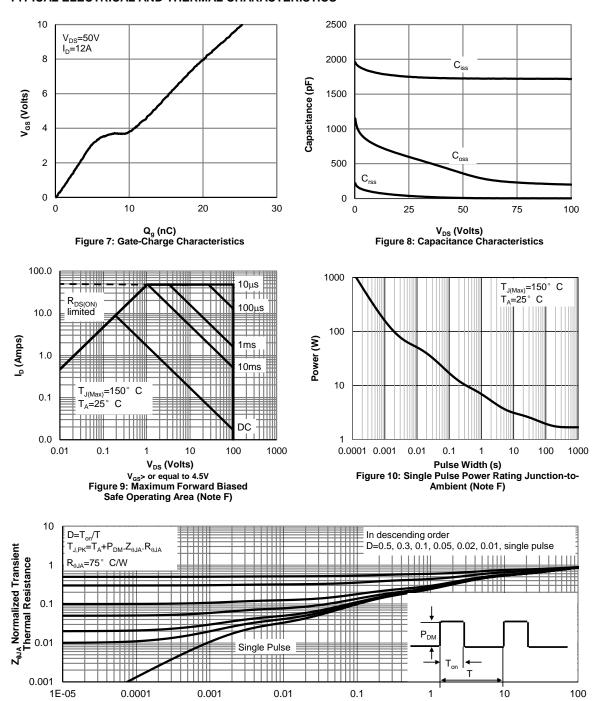


(Note E)





TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



Figure A: Gate Charge Test Circuit & Waveforms

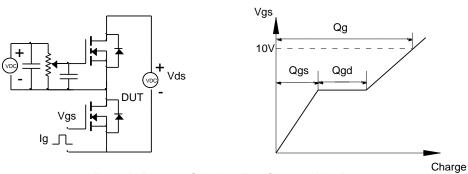


Figure B: Resistive Switching Test Circuit & Waveforms

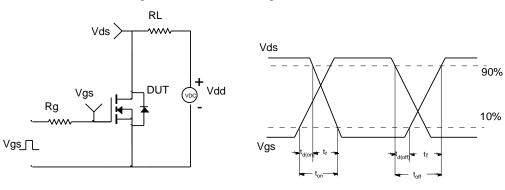


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

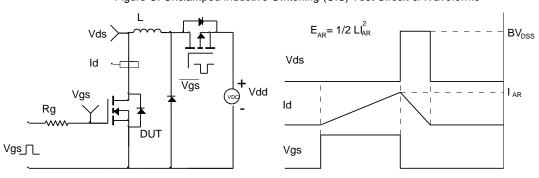


Figure D: Diode Recovery Test Circuit & Waveforms

